## FFS40120AF-DIE

## Silicon Carbide Schottky Diode

## 1200 V, 40 A

## Description

Silicon Carbide (SiC) Schottky Diodes use a completely new technology that provides superior switching performance and higher reliability compared to Silicon. No reverse recovery current, temperature dependent switching characteristics, and excellent thermal performance sets Silicon Carbide as the next generation of power semiconductor. System benefits include highest efficiency, faster operation frequency, increased power density, reduced EMI, and reduced system size and cost.

## Features

- Max Junction Temperature $175^{\circ} \mathrm{C}$
- Avalanche Rated 420 mJ
- High Surge Current Capacity
- Positive Temperature Coefficient
- Ease of Paralleling
- No Reverse Recovery/No Forward Recovery


## Applications

- General Purpose
- SMPS, Solar Inverter, UPS
- Power Switching Circuits


## Die Information

- Wafer Diameter: 6 inch
- Die Size: 4,200 $\times 4,200 \mu \mathrm{~m}$ (include Scribe Lane)
- Metallization:
- Top Ti/TiN/AlCu $4 \mu \mathrm{~m}$
- Back Ti/NiV/Ag
- Die Thickness: Typ. $200 \mu \mathrm{~m}$
- Bonding Pad Size
- Anode 3,620 $\times$ 3,620 $\mu \mathrm{m}$
- Recommended Wire Bond (Note 1)
- Anode: $20 \mathrm{mil} \times 3$

ON Semiconductor ${ }^{\circledR}$
www.onsemi.com


## ORDERING INFORMATION

See detailed ordering and shipping information on page 3 of this data sheet.

ELECTRICAL CHARACTERISTICS ON WAFER (NOTE $\left.{ }^{2}\right)\left(\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}\right.$ unless otherwise noted) (Note 2)

| Symbol | Parameter | Test Condition | Min | Typ | Max | Unit |
| :---: | :--- | :--- | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\mathrm{R}}$ | Reverse Blocking Voltage | $\mathrm{I}_{\mathrm{R}}=200 \mu \mathrm{~A}, \mathrm{~T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ | 1200 | - | - | V |
| $\mathrm{V}_{\mathrm{F}}$ | Forward Voltage | $\mathrm{I}_{\mathrm{F}}=40 \mathrm{~A}, \mathrm{~T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ | 1.20 | - | 1.75 | V |
| $\mathrm{I}_{\mathrm{R}}$ | Reverse Current | $\mathrm{V}_{\mathrm{R}}=1200 \mathrm{~V}, \mathrm{~T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ | - | - | 200 | $\mu \mathrm{~A}$ |

## NOTES:

1. Based on TO-247 package of ON Semiconductor.
2. Tested $100 \%$ on wafer


Figure 1. Die Layout

Cross Section


Figure 2. Cross Section

## Passivation Information

- Passivation Material: Polymide (PSPI)
- Passivation Type: Local Passivation
- Passivation Thickness: 90 KA


## The Configuration of Chips (Based on 6" Wafer)



Figure 3. Saw-on-film Frame Packing Based on Tested Wafer

ABSOLUTE MAXIMUM RATINGS ( $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ unless otherwise noted)

| Symbol | Parameter |  | Value | Unit |
| :---: | :---: | :---: | :---: | :---: |
| $V_{\text {RRM }}$ | Peak Repetitive Reverse Voltage |  | 1200 | V |
| $\mathrm{E}_{\text {AS }}$ | Single Pulse Avalanche Energy (Note 3) |  | 420 | mJ |
| $\mathrm{I}_{\mathrm{F}}$ | Continuous Rectified Forward Current @ $\mathrm{T}_{\mathrm{C}}<155^{\circ} \mathrm{C}$ |  | 40 | A |
|  | Continuous Rectified Forward Current @ $\mathrm{T}_{\mathrm{C}}<135^{\circ} \mathrm{C}$ |  | 61 |  |
| $\mathrm{I}_{\mathrm{F}, \mathrm{Max}}$ | Non-Repetitive Peak Forward Surge Current | $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}, 10 \mu \mathrm{~s}$ | 1650 | A |
|  |  | $\mathrm{T}_{\mathrm{C}}=150^{\circ} \mathrm{C}, 10 \mu \mathrm{~s}$ | 1550 | A |
| $\mathrm{I}_{\mathrm{F}, \mathrm{SM}}$ | Non-Repetitive Forward Surge Current | Half-Sine Pulse, $\mathrm{t}_{\mathrm{p}}=8.3 \mathrm{~ms}$ | 270 | A |
| $\mathrm{I}_{\mathrm{F}, \mathrm{RM}}$ | Repetitive Forward Surge Current | Half-Sine Pulse, $\mathrm{t}_{\mathrm{p}}=8.3 \mathrm{~ms}$ | 120 | A |
| Ptot | Power Dissipation | $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ | 682 | W |
|  |  | $\mathrm{T}_{\mathrm{C}}=150^{\circ} \mathrm{C}$ | 114 | W |
| $\mathrm{T}_{\mathrm{J},} \mathrm{T}_{\text {STG }}$ | Operating and Storage Temperature Range |  | -55 to +175 | ${ }^{\circ} \mathrm{C}$ |
|  | TO247 Mounting Torque, M3 Screw |  | 60 | Ncm |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.
3. $\mathrm{E}_{\mathrm{AS}}$ of 420 mJ is based on starting $\mathrm{T}_{J}=25^{\circ} \mathrm{C}, \mathrm{L}=0.5 \mathrm{mH}, \mathrm{I}_{\mathrm{AS}}=41 \mathrm{~A}, \mathrm{~V}=50 \mathrm{~V}$.

THERMAL CHARACTERISTICS

| Symbol | Parameter | Value | Unit |
| :---: | :--- | :---: | :---: |
| $\mathrm{R}_{\text {өJC }}$ | Thermal Resistance, Junction to Case, Max | 0.22 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |

ELECTRICAL CHARACTERISTICS $\left(T_{C}=25^{\circ} \mathrm{C}\right.$ unless otherwise noted)

| Symbol | Parameter | Test Condition | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $V_{F}$ | Forward Voltage | $\mathrm{I}_{\mathrm{F}}=40 \mathrm{~A}, \mathrm{~T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ | - | 1.45 | 1.75 | V |
|  |  | $\mathrm{I}_{\mathrm{F}}=40 \mathrm{~A}, \mathrm{~T}_{\mathrm{C}}=125^{\circ} \mathrm{C}$ | - | 1.7 | 2.0 |  |
|  |  | $\mathrm{I}_{\mathrm{F}}=40 \mathrm{~A}, \mathrm{~T}_{\mathrm{C}}=175^{\circ} \mathrm{C}$ | - | 2.0 | 2.4 |  |
| $\mathrm{I}_{\mathrm{R}}$ | Reverse Current | $\mathrm{V}_{\mathrm{R}}=1200 \mathrm{~V}, \mathrm{~T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ | - | - | 200 | $\mu \mathrm{A}$ |
|  |  | $\mathrm{V}_{\mathrm{R}}=1200 \mathrm{~V}, \mathrm{~T}_{\mathrm{C}}=125^{\circ} \mathrm{C}$ | - | - | 300 |  |
|  |  | $\mathrm{V}_{\mathrm{R}}=1200 \mathrm{~V}, \mathrm{~T}_{\mathrm{C}}=175^{\circ} \mathrm{C}$ | - | - | 400 |  |
| $\mathrm{Q}_{\mathrm{C}}$ | Total Capacitive Charge | $\mathrm{V}=800 \mathrm{~V}$ | - | 220 | - | nC |
| C | Total Capacitance | $\mathrm{V}_{\mathrm{R}}=1 \mathrm{~V}, \mathrm{f}=100 \mathrm{kHz}$ | - | 2250 | - | pF |
|  |  | $\mathrm{V}_{\mathrm{R}}=400 \mathrm{~V}, \mathrm{f}=100 \mathrm{kHz}$ | - | 204 | - |  |
|  |  | $\mathrm{V}_{\mathrm{R}}=800 \mathrm{~V}, \mathrm{f}=100 \mathrm{kHz}$ | - | 169 | - |  |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

## PACKAGE MARKING AND ORDERING INFORMATION

| Part Number | Top Marking | Package | Shipping |
| :---: | :---: | :---: | :---: |
| FFSH40120A | FFSH40120A | TO-247-2LD <br> (Halogen Free) | 30 Units / Tube |

## TYPICAL CHARACTERISTICS

( $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$ unless otherwise noted)


Figure 4. Forward Characteristics


Figure 6. Current Derating


Figure 8. Capacitive Charge vs. Reverse Voltage


Figure 5. Reverse Characteristics


Figure 7. Power Derating


Figure 9. Capacitance vs. Reverse Voltage

## TYPICAL CHARACTERISTICS

( $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$ unless otherwise noted)


Figure 10. Capacitance Stored Energy


Figure 11. Junction-to-Case Transient Thermal Response Curve

## TEST CIRCUIT AND WAVEFORMS



Figure 12. Unclamped Inductive Switching Test Circuit \& Waveform
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